

Automotive-grade N-channel 30 V, 25 mΩ typ., 10 A STripFET™ H6 Power MOSFET in a DPAK package

Datasheet - production data

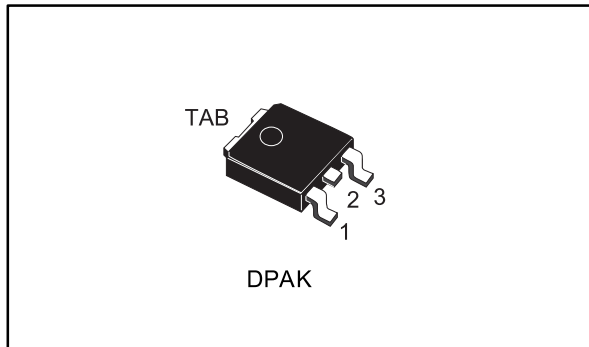
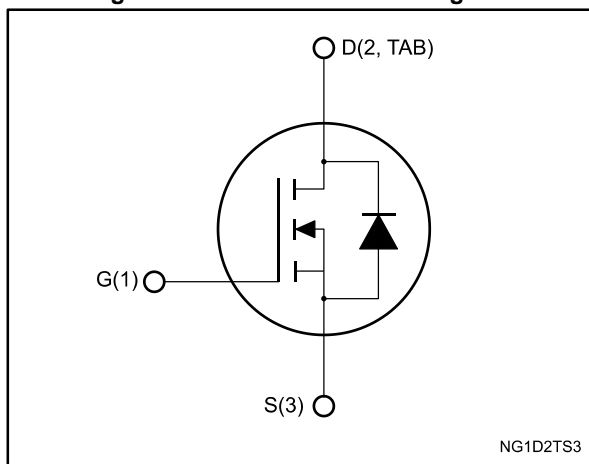


Figure 1: Internal schematic diagram



Features

| Order code | V _{DS} | R _{DS(on)} max. | I _D | P _{TOT} |
|---------------|-----------------|--------------------------|----------------|------------------|
| STD19N3LLH6AG | 30 V | 33 mΩ | 10 A | 30 W |

- Designed for automotive applications and AEC-Q101 qualified
- Very low on-resistance
- Very low gate charge
- High avalanche ruggedness
- Low gate drive power loss
- Logic level

Applications

- Switching applications

Description

This device is an N-channel Power MOSFET developed using the STripFET™ H6 technology with a new trench gate structure. The resulting Power MOSFET exhibits very low R_{DS(on)} in all packages.

Table 1: Device summary

| Order code | Marking | Package | Packing |
|---------------|----------|---------|---------------|
| STD19N3LLH6AG | 19N3LLH6 | DPAK | Tape and reel |

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1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|-------------------------|--|------------|------|
| V_{DS} | Drain-source voltage | 30 | V |
| V_{GS} | Gate-source voltage | ± 20 | V |
| I_D | Drain current (continuous) at $T_{case} = 25\text{ °C}$ ⁽¹⁾ | 10 | A |
| | Drain current (continuous) at $T_{case} = 100\text{ °C}$ | 10 | |
| I_{DM} ⁽²⁾ | Drain current (pulsed) | 40 | A |
| P_{TOT} | Total dissipation at $T_{case} = 25\text{ °C}$ | 30 | W |
| T_{stg} | Storage temperature | -55 to 175 | °C |
| T_j | Operating junction temperature | | |

Notes:

⁽¹⁾ Current limited by package. At $T_{case} = 25\text{ °C}$ the silicon is able to sustain 22 A.

⁽²⁾ Pulse width limited by safe operating area.

Table 3: Thermal data

| Symbol | Parameter | Value | Unit |
|------------------------------|----------------------------------|-------|------|
| $R_{thj-case}$ | Thermal resistance junction-case | 5 | °C/W |
| $R_{thj-pcb}$ ⁽¹⁾ | Thermal resistance junction-pcb | 50 | |

Notes:

⁽¹⁾When mounted on a 1-inch² FR-4, 2 Oz copper board.

Table 4: Avalanche characteristics

| Symbol | Parameter | Value | Unit |
|-------------------------|---|-------|------|
| I_{AV} ⁽¹⁾ | Avalanche current, repetitive or not repetitive | 10 | A |
| E_{AS} ⁽²⁾ | Single pulse avalanche energy | 130 | mJ |

Notes:

⁽¹⁾ Pulse width limited by T_{jmax} .

⁽²⁾ starting $T_j = 25\text{ °C}$, $I_D = I_{AV}$, $V_{DD} = 25\text{ V}$.

2 Electrical characteristics

($T_{\text{case}} = 25\text{ °C}$ unless otherwise specified)

Table 5: Static

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------|-----------------------------------|---|------|------|-----------|---------------|
| $V_{(\text{BR})\text{DSS}}$ | Drain-source breakdown voltage | $V_{\text{GS}} = 0\text{ V}$, $I_{\text{D}} = 250\text{ }\mu\text{A}$ | 30 | | | V |
| I_{DSS} | Zero gate voltage drain current | $V_{\text{GS}} = 0\text{ V}$, $V_{\text{DS}} = 30\text{ V}$ | | | 1 | μA |
| | | $V_{\text{GS}} = 0\text{ V}$, $V_{\text{DS}} = 30\text{ V}$, $T_{\text{case}} = 125\text{ °C}$ | | | 100 | μA |
| I_{GSS} | Gate-body leakage current | $V_{\text{DS}} = 0\text{ V}$, $V_{\text{GS}} = \pm 20\text{ V}$ | | | ± 100 | nA |
| $V_{\text{GS}(\text{th})}$ | Gate threshold voltage | $V_{\text{DS}} = V_{\text{GS}}$, $I_{\text{D}} = 250\text{ }\mu\text{A}$ | 1 | | 2.5 | V |
| $R_{\text{DS}(\text{on})}$ | Static drain-source on-resistance | $V_{\text{GS}} = 10\text{ V}$, $I_{\text{D}} = 5\text{ A}$ | | 25 | 33 | m Ω |
| | | $V_{\text{GS}} = 4.5\text{ V}$, $I_{\text{D}} = 5\text{ A}$ | | 33 | 50 | |

Table 6: Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-------------------|------------------------------|--|------|------|------|------|
| C_{iss} | Input capacitance | $V_{\text{DS}} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{\text{GS}} = 0\text{ V}$ | - | 321 | - | pF |
| C_{oss} | Output capacitance | | - | 68 | - | |
| C_{riss} | Reverse transfer capacitance | | - | 34 | - | |
| Q_{g} | Total gate charge | $V_{\text{DD}} = 15\text{ V}$, $I_{\text{D}} = 10\text{ A}$, $V_{\text{GS}} = 4.5\text{ V}$ (see Figure 14: "Test circuit for gate charge behavior") | - | 3.7 | - | nC |
| Q_{gs} | Gate-source charge | | - | 1 | - | |
| Q_{gd} | Gate-drain charge | | - | 1.7 | - | |

Table 7: Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------------------|---------------------|--|------|------|------|------|
| $t_{\text{d}(\text{on})}$ | Turn-on delay time | $V_{\text{DD}} = 15\text{ V}$, $I_{\text{D}} = 5\text{ A}$ $R_{\text{G}} = 4.7\text{ }\Omega$, $V_{\text{GS}} = 10\text{ V}$ (see Figure 13: "Test circuit for resistive load switching times" and Figure 18: "Switching time waveform") | - | 2.4 | - | ns |
| t_{r} | Rise time | | - | 2.5 | - | |
| $t_{\text{d}(\text{off})}$ | Turn-off delay time | | - | 12.8 | - | |
| t_{f} | Fall time | | - | 2.5 | - | |

Table 8: Source-drain diode

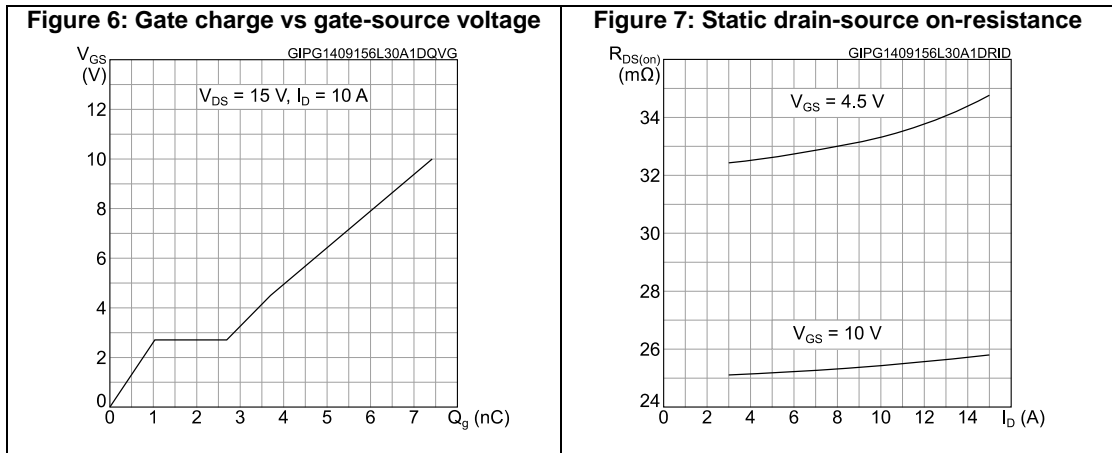
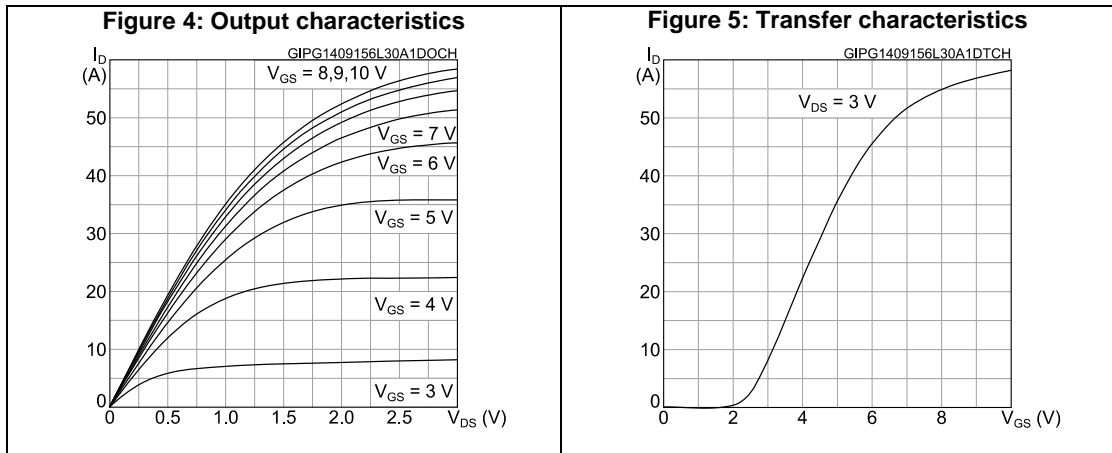
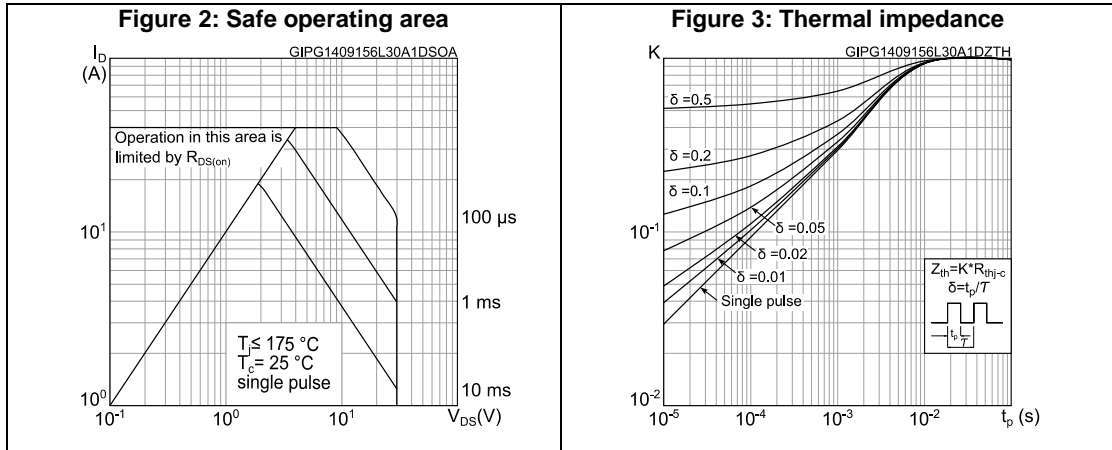
| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|---|------|------|------|------|
| I_{SD} | Source-drain current | | - | | 10 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | - | | 40 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $V_{GS} = 0\text{ V}$, $I_{SD} = 10\text{ A}$ | - | | 1.12 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 10\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $V_{DD} = 24\text{ V}$ (see Figure 15 : "Test circuit for inductive load switching and diode recovery times") | - | 15.1 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 7.5 | | nC |
| I_{RRM} | Reverse recovery current | | - | 1 | | A |

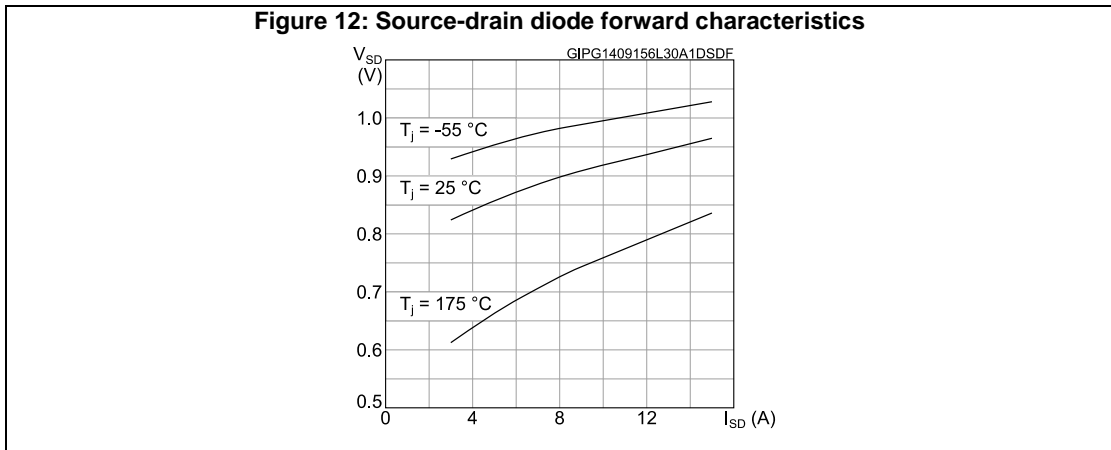
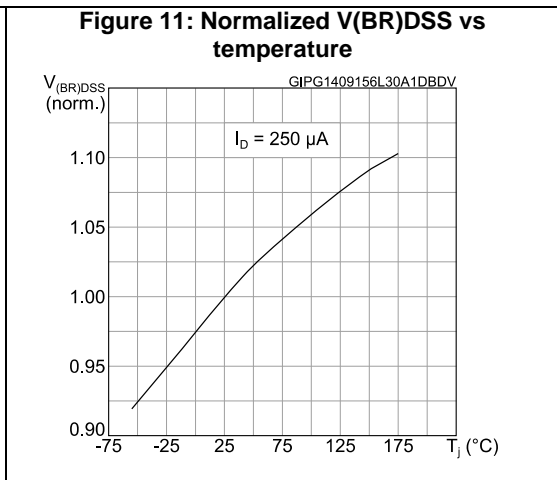
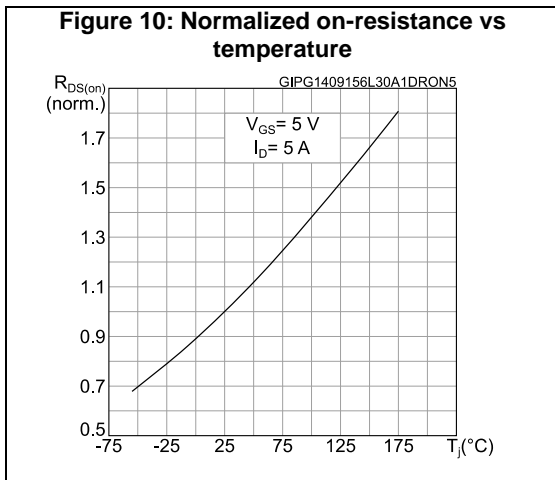
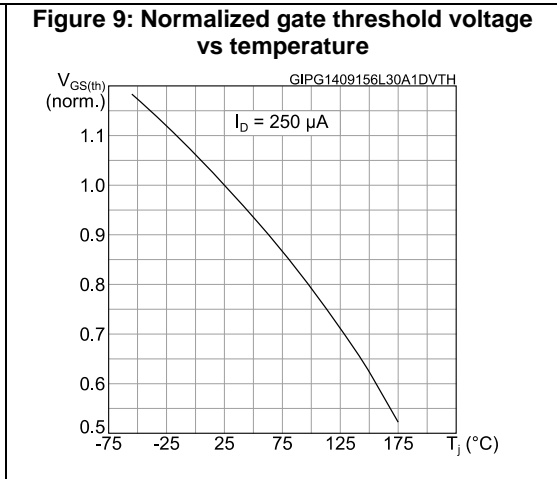
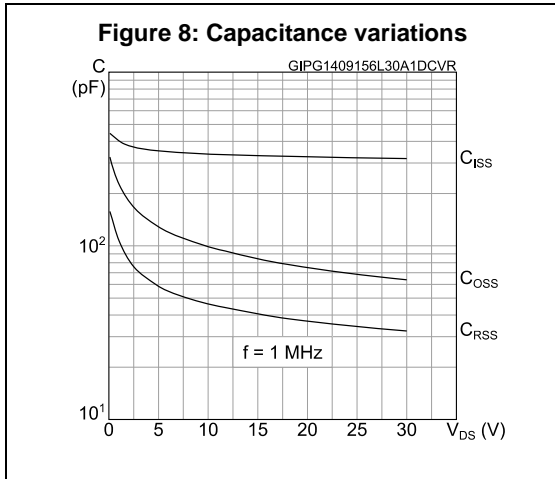
Notes:

(1) Pulse width is limited by safe operating area.

(2) Pulse test: pulse duration = 300 μs , duty cycle 1.5%.

2.1 Electrical characteristics (curves)





3 Test circuits

Figure 13: Test circuit for resistive load switching times



AM01468v1

Figure 14: Test circuit for gate charge behavior



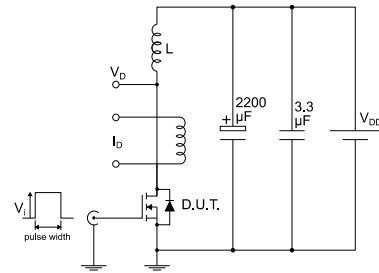
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Figure 15: Test circuit for inductive load switching and diode recovery times



AM01470v1

Figure 16: Unclamped inductive load test circuit



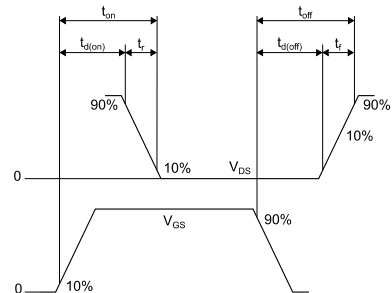
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Figure 17: Unclamped inductive waveform



AM01472v1

Figure 18: Switching time waveform



AM01473v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 DPAK (TO-252) type A package information

Figure 19: DPAK (TO-252) type A package outline

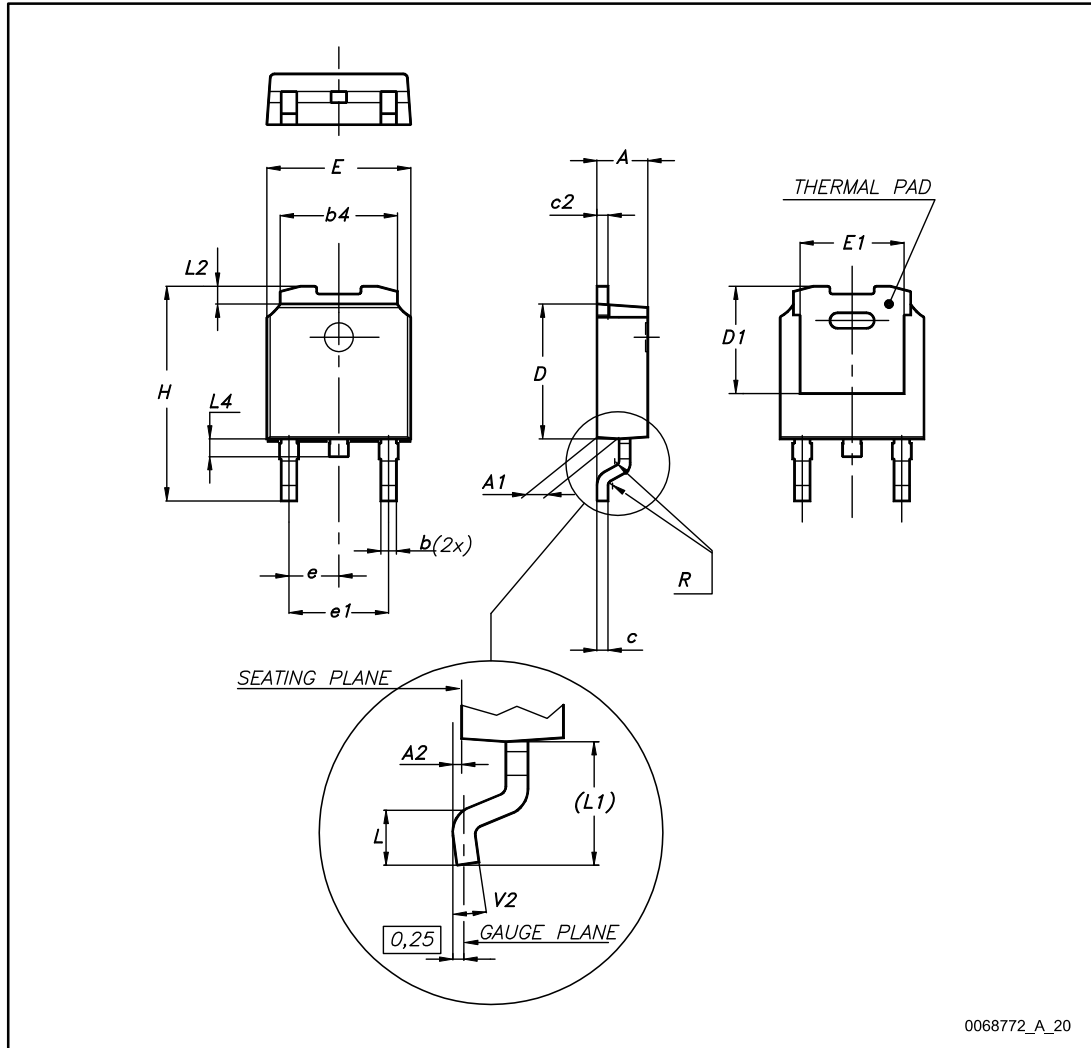
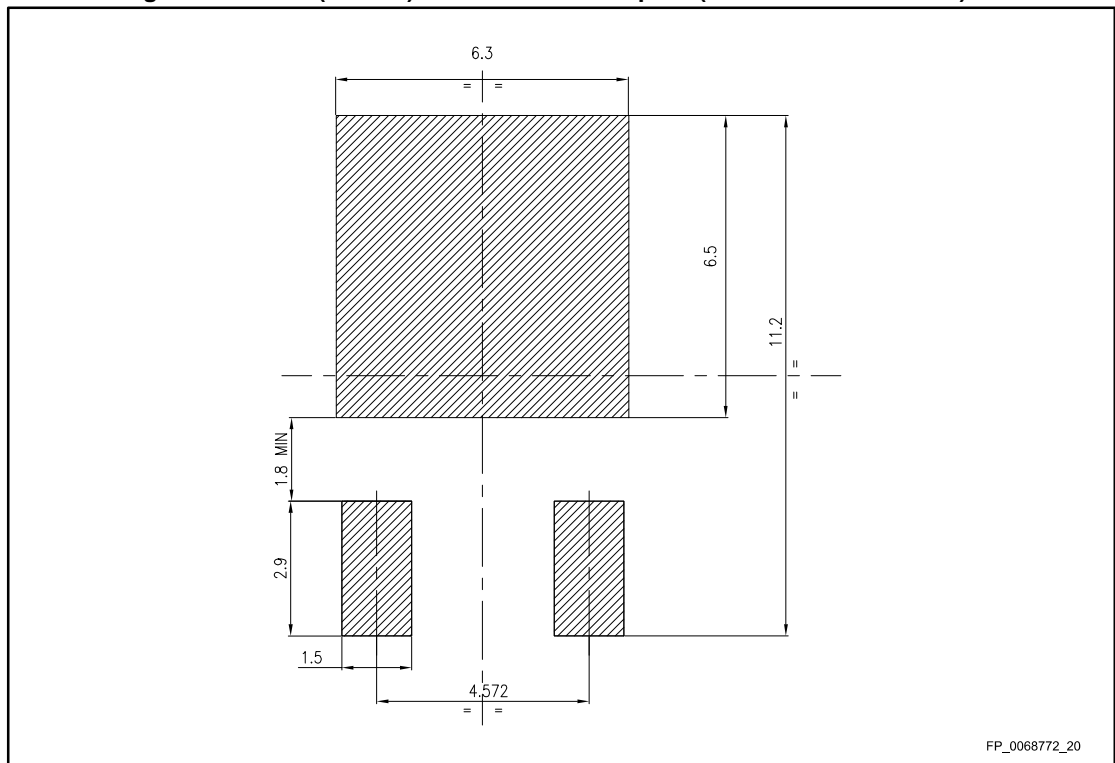


Table 9: DPAK (TO-252) type A mechanical data

| Dim. | mm | | |
|------|------|------|-------|
| | Min. | Typ. | Max. |
| A | 2.20 | | 2.40 |
| A1 | 0.90 | | 1.10 |
| A2 | 0.03 | | 0.23 |
| b | 0.64 | | 0.90 |
| b4 | 5.20 | | 5.40 |
| c | 0.45 | | 0.60 |
| c2 | 0.48 | | 0.60 |
| D | 6.00 | | 6.20 |
| D1 | 4.95 | 5.10 | 5.25 |
| E | 6.40 | | 6.60 |
| E1 | 4.60 | 4.70 | 4.80 |
| e | 2.16 | 2.28 | 2.40 |
| e1 | 4.40 | | 4.60 |
| H | 9.35 | | 10.10 |
| L | 1.00 | | 1.50 |
| (L1) | 2.60 | 2.80 | 3.00 |
| L2 | 0.65 | 0.80 | 0.95 |
| L4 | 0.60 | | 1.00 |
| R | | 0.20 | |
| V2 | 0° | | 8° |

Figure 20: DPAK (TO-252) recommended footprint (dimensions are in mm)



4.2 DPAK (TO-252) packing information

Figure 21: DPAK (TO-252) tape outline

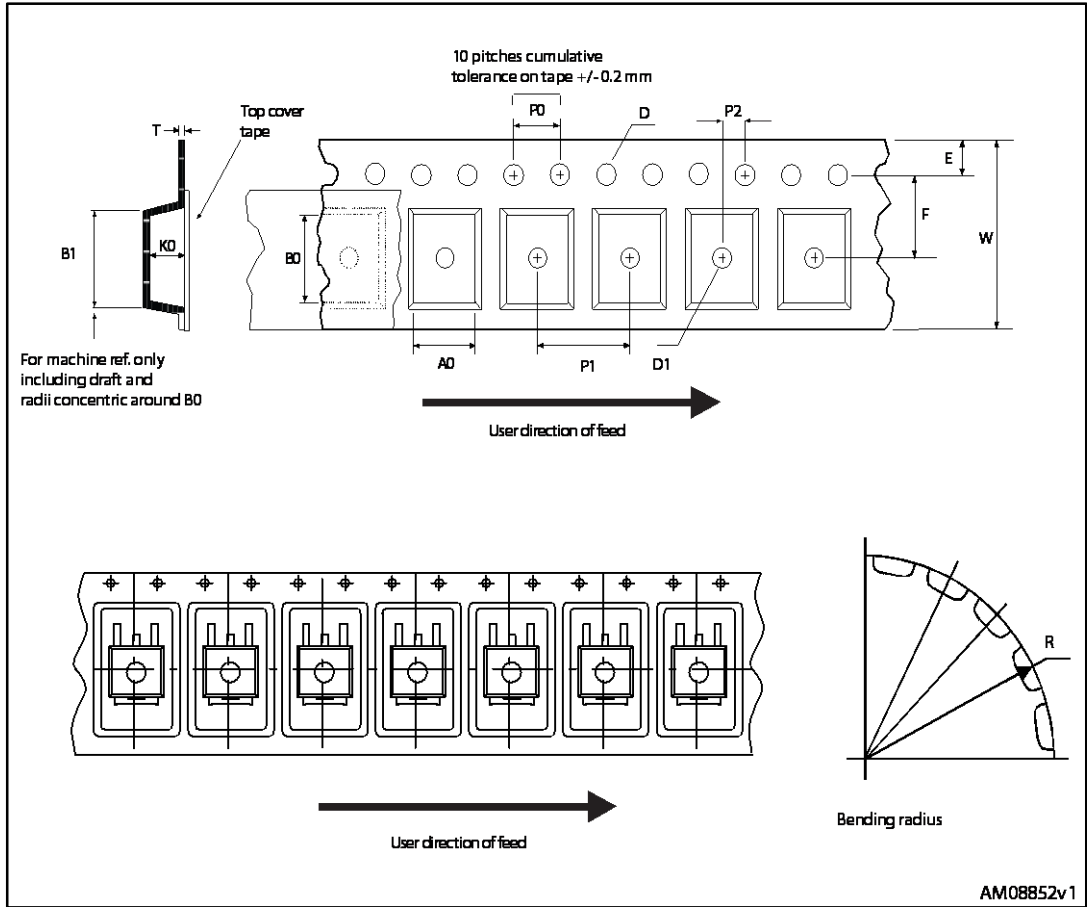


Figure 22: DPAK (TO-252) reel outline

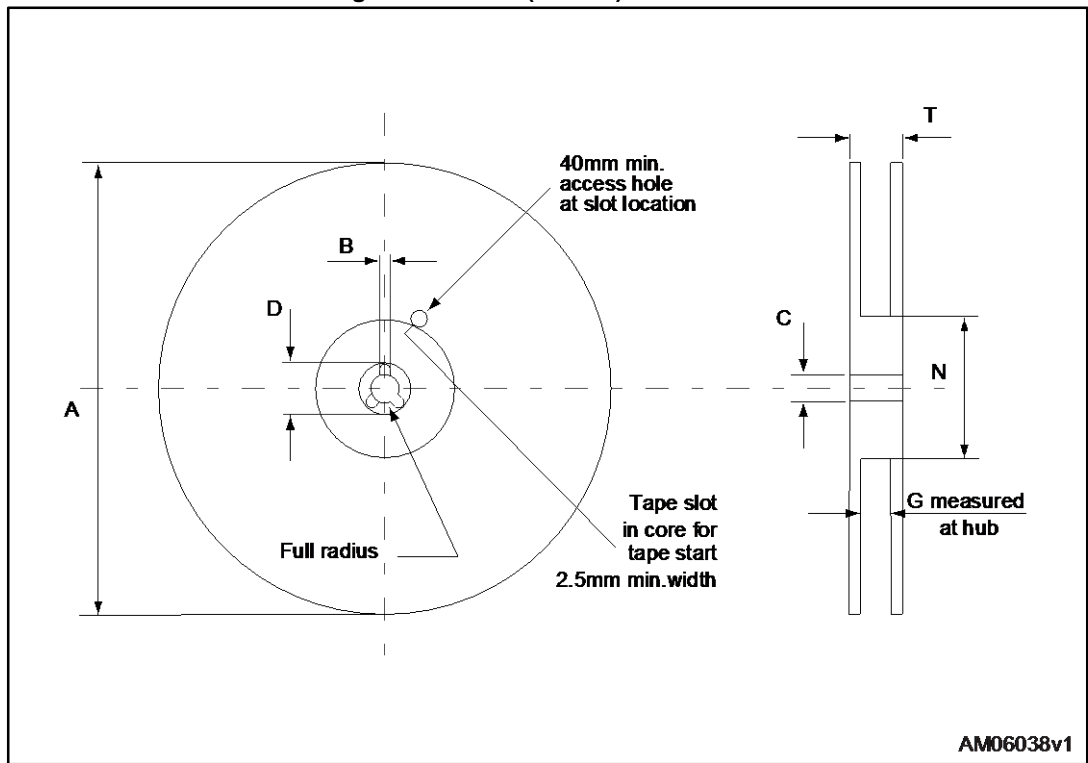


Table 10: DPAK (TO-252) tape and reel mechanical data

| Tape | | | Reel | | |
|------|------|------|-----------|------|------|
| Dim. | mm | | Dim. | mm | |
| | Min. | Max. | | Min. | Max. |
| A0 | 6.8 | 7 | A | | 330 |
| B0 | 10.4 | 10.6 | B | 1.5 | |
| B1 | | 12.1 | C | 12.8 | 13.2 |
| D | 1.5 | 1.6 | D | 20.2 | |
| D1 | 1.5 | | G | 16.4 | 18.4 |
| E | 1.65 | 1.85 | N | 50 | |
| F | 7.4 | 7.6 | T | | 22.4 |
| K0 | 2.55 | 2.75 | | | |
| P0 | 3.9 | 4.1 | Base qty. | | 2500 |
| P1 | 7.9 | 8.1 | Bulk qty. | | 2500 |
| P2 | 1.9 | 2.1 | | | |
| R | 40 | | | | |
| T | 0.25 | 0.35 | | | |
| W | 15.7 | 16.3 | | | |

5 Revision history

Table 11: Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 01-Oct-2015 | 1 | Initial version |
| 13-Oct-2015 | 2 | On cover page: - updated title In section Electrical characteristics: - updated table Dynamic Updated section Test circuits |

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